

STY30NK90Z

N-channel 900V - 0.21Ω - 26A - Max247 Zener-protected SuperMESH[™] Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D	p _W
STY30NK90Z	900V	<0.26Ω	28A	500W

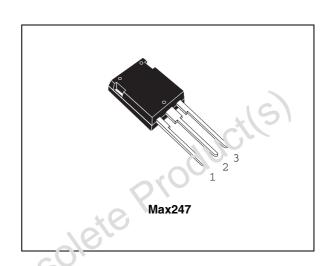
- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatibility

Description

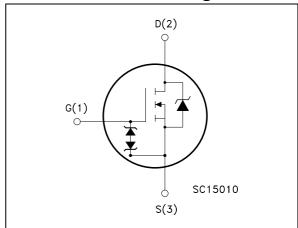
The SuperMESHTM series is obtained through an extreme optimization of ST's well established strip-based PowerMESHTM layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including re relationary MDmeshTM products.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STY30NK90Z	Y30NK90Z	Max247	Tube

Contents STY30NK90Z

Contents

1	Electrical ratings 3
	1.1 Protection features of gate-to-source zener diodes
2	Electrical characteristics5
	2.1 Electrical characteristics (curves)
3	Test circuit9
4	Package mechanical data
5	Revision history
0050	Electrical ratings

STY30NK90Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	900	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25°C	26	Α
I _D	Drain current (continuous) at T _C = 100°C	16	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	104	A
P _{tot}	Total dissipation at T _C = 25°C	450	W
	Derating Factor	3.57	W/°C
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	6000	V
dv/dt (2)	Peak diode recovery voltage slope	1.5	V/ns
T _{stg}	Storage temperature	-65 to 150	°C
Tj	Max. operating junction temperature	-03 (0 150	O

^{1.} Pulse width limited by safe operating area.

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	0.277	°C/W
Rthj-amb	Thermal resistance junction-ambient max	30	°C/W
T _J	M. ixinum lead temperature for soldering purpose	300	°C

Table 3. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	26	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 35$ V)	500	mJ

Table 4. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-source breakdown voltage	Igs=± 1mA (open drain)	30			V

^{2.} I_{SD} \$\text{26A}, di/dt \$\leq 400A/\mu s\$, $V_{DD} \leq V_{(BR)DSS}$, $T_{J} = T_{JL'AX}$

Electrical ratings STY30NK90Z

1.1 Protection features of gate-to-source zener diodes

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

4/14

577

Obsolete Product(s). Obsolete Product(s)

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1mA, V _{GS} =0	900			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} = max rating, T_{C} = 125°C			10 100	μΑ Au
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20V		AU	±100	μА
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$	3	3.7 <i>ŝ</i>	4.5	٧
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 14A		0.21	0.26	Ω

Table 6. Dynamic

	Symbol	Parameter	7 st conditions	Min.	Тур.	Max.	Unit
	9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V _, I _D = 14A		26		S
	C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1MHz,$ $V_{GS} = 0$		12000 852 166		pF pF pF
	Coss eq (C)	Equivalent output capacitance	$V_{GS} = 0V$, $V_{DS} = 0V$ to 720V		377		pF
Obsole	t _d (on) t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 450V, I_D = 13A R_G = 4.7 Ω V_{GS} = 10V (see <i>Figure 13</i>)		67 59 250 72		ns ns ns
	Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 720V, I_{D} = 26A,$ $V_{GS} = 10V, R_{G} = 4.7\Omega$ (see <i>Figure 14</i>)		350 51 190	490	nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %.

^{2.} Coss eq. is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Electrical characteristics STY30NK90Z

Table 7. Source drain diode

$I_{SD} = 28A$, $V_{GS} = 0$ $I_{SD} = 26A$, $di/dt = 100A/\mu s$, $V_{DD} = 100V$, $T_j = 25^{\circ}C$ (see <i>Figure 15</i>) $I_{SD} = 26A$, $di/dt = 100A/\mu s$, $V_{DD} = 100V$, $T_j = 150^{\circ}C$ (see <i>Figure 15</i>) ea. ccle 1.5 %	Sic	1 18.9 36.6 1.33 25.2 37.8	28 112 2	A A V μs μC A μs ιC A
$I_{SD} = 26A$, di/dt = 100A/ μ s, $V_{DD} = 100V$, $T_j = 25$ °C (see <i>Figure 15</i>) $I_{SD} = 26A$, di/dt = 100A/ μ s,	Sic	18.9 36.6 1.33		μs μC A μs ιC
$V_{DD} = 100V$, $T_j = 25$ °C (see <i>Figure 15</i>) $I_{SD} = 26A$, di/dt = $100A/\mu s$,	Sic	18.9 36.6 1.33	-ile	μC A μs ιC
-	SKC		ile.	ιC
ea. ccle 1.5 %	Sic	gill		
16/10				
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	0050	Obso.	Obsor	V _{DD} = 100V, T _j = 150°C (see <i>Figure 15</i>) 25.2 37.8 29. 29. 29. 29. 29. 29. 29. 29. 29. 29.

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

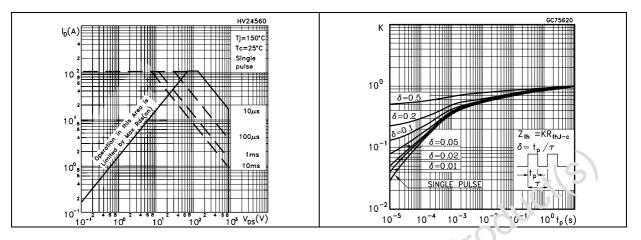


Figure 3. Output characterisics

Figure 4. Transfer characteristics

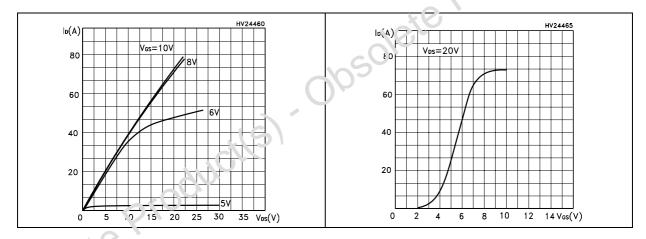
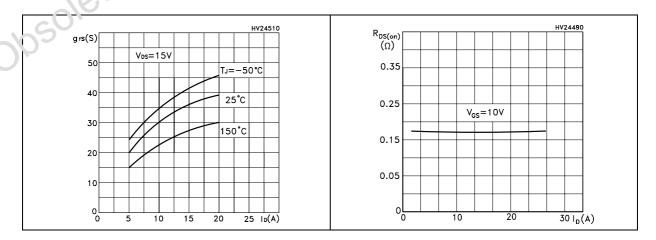


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



Electrical characteristics STY30NK90Z

Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

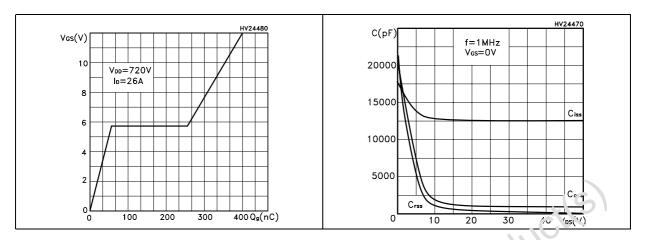


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

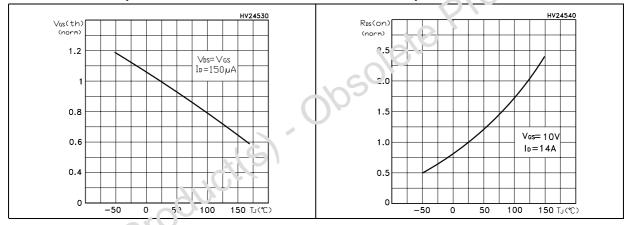
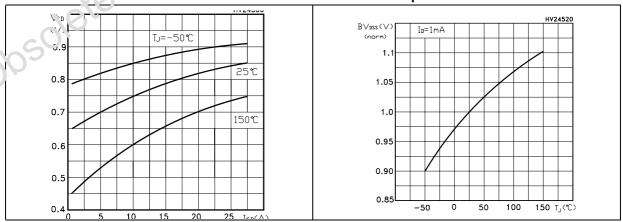


Figure 11. Source drain diode forward characteristics

Figure 12. Normalized breakdown voltage vs temperature



STY30NK90Z Test circuit

3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

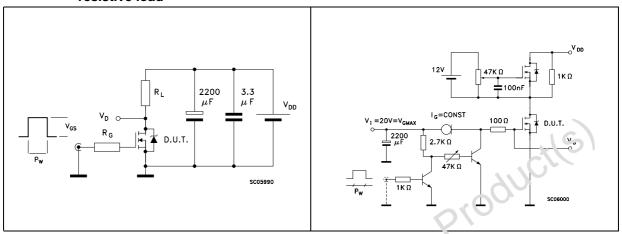
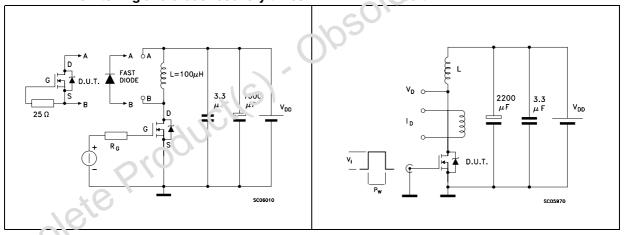


Figure 15. Test circuit for inductive load switching and diode recovery times

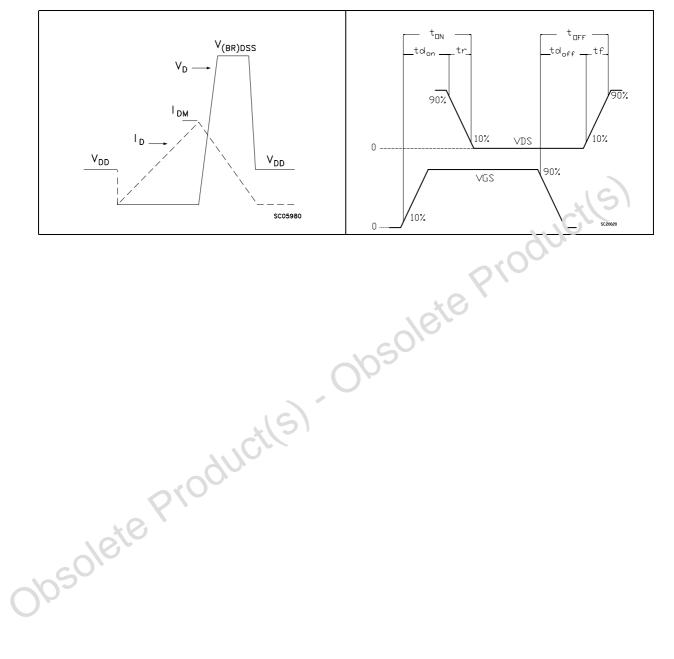
Figure 16. Unalamped Inductive load test



Test circuit STY30NK90Z

Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



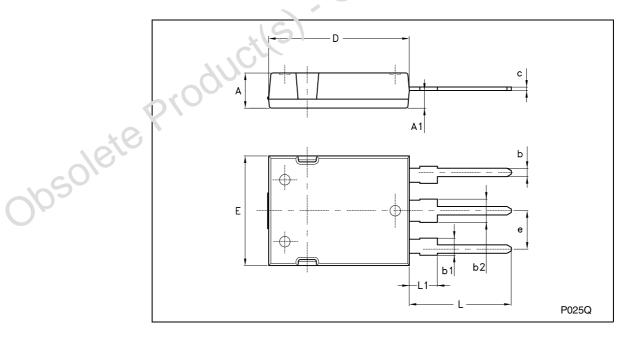
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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Max247 MECHANICAL DATA

DIM.		mm			inch	
DIWI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	4.70		5.30			
A1	2.20		2.60			
b	1.00		1.40			.10
b1	2.00		2.40			
b2	3.00		3.40		11	70.
С	0.40		0.80		00	
D	19.70		20.30		10	
е	5.35		5.55	\ \ \	ĺ	
Е	15.30		15.90	1.0		
L	14.20		15.20	0,1		
L1	3.70		4.30			



STY30NK90Z Revision history

5 Revision history

Table 8. Revision history

Date	Revision	Changes
16-Jul-2004	1	First release
23-Mar-2004	2	New ECOPACK label inserted
21-Jan-2005	3	Complete document with curves
16-Oct-2006	4	New template, no content change
ite Prod	ucils	New template, no content change

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